

WESTCODE

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 Rat Rep : 99T13
 Issue 2

Converter thyristor

Type N1883xx12xxx to N1883xx28xxx

Absolute maximum ratings

	VOLTAGE RATINGS	MAXIMUM LIMITS	UNITS
V_{DRM}	Repetitive peak off-state voltage, (note 1).	1200-2800	V
V_{DSM}	Non-repetitive peak off-state voltage, (note 1).	1200-2800	V
V_{RRM}	Repetitive peak reverse voltage, (note 1).	1200-2800	V
V_{RSM}	Non-repetitive peak reverse voltage, (note 1).	1300-2900	V

	RATINGS	MAXIMUM LIMITS	UNITS
$I_{T(AV)}$	Mean on-state current, $T_{sink}=55^{\circ}C$, (note 2).	4145	A
$I_{T(AV)}$	Mean on-state current, $T_{sink}=85^{\circ}C$, (note 5).	2854	A
$I_{T(AV)}$	Mean on-state current, $T_{sink}=85^{\circ}C$, (note 3).	1735	A
$I_{T(RMS)}$	Nominal RMS on-state current, $25^{\circ}C$, (note 2).	8170	A
$I_{T(d.c.)}$	D.C. on-state current, $25^{\circ}C$, (note 7).	7115	A
I_{TSM}	Peak non-repetitive surge $t_p=10ms$, $V_{RM}=0.6V_{RRM}$, (note 4).	67.5×10^3	A
I_{TSM2}	Peak non-repetitive surge $t_p=10ms$, $V_{RM} \leq 10V$, (note 4).	75.0×10^3	A
I^2t	I^2t capacity for fusing $t_p=10ms$, $V_{RM}=0.4V_{RRM}$, (note 4).	22.8×10^6	A^2s
I^2t	I^2t capacity for fusing $t_p=10ms$, $V_{RM} \leq 10V$, (note 4).	28.1×10^6	A^2s
I^2t	I^2t capacity for fusing $t_p=3ms$, $V_{RM} \leq 0.4V_{RRM}$, (note 4).	10.8×10^6	A^2s
di/dt	Critical rate of rise of on-state current (continuous), (note 6).	150	$A/\mu s$
	Critical rate of rise of on-state current (Intermittent), (note 6).	300	$A/\mu s$
I_{FGM}	Peak forward gate current.	10	A
V_{RGM}	Peak reverse gate voltage.	5	V
$P_{G(AV)}$	Mean forward gate power.	5	W
P_{GM}	Peak forward gate power.	30	W
V_{GD}	Non-trigger gate voltage, (Note 5).	0.25	V
T_{HS}	Operating temperature range.	-40 to +125	$^{\circ}C$
T_{stg}	Storage temperature range.	-40 to +150	$^{\circ}C$

Notes:-

- 1) De-rating factor of 0.13% per K is applicable for T_j below $25^{\circ}C$.
- 2) Doubleside cooled, single phase; 50Hz, 180° half-sinewave.
- 3) Singleside cooled, single phase; 50Hz, 180° half-sinewave.
- 4) Half-sinewave, $125^{\circ}C T_j$ initial.
- 5) Rated V_{DRM} .
- 6) $V_D=67\%V_{DRM}$, $I_T=6000A$, $I_{FG}=2A$, $t_r=500ns$.
- 7) Doubleside cooled.

Characteristics

	CHARACTERISTICS	MIN	TYP	MAX	TEST CONDITIONS	UNITS
V_{TM}	Maximum peak on-state voltage.	-	-	1.40	$I_T=6000A.$	V
V_0	Threshold voltage.	-	-	0.80		V
R_T	Slope resistance.	-	-	0.1		$m\Omega$
dv/dt	Critical rate of rise of off-state voltage.	200	1000	2000	$V_D=80\% V_{DRM}.$	$V/\mu s$
I_{DRM}	Peak off-state current.	-	-	300	Rated V_{DRM} , note 2.	mA
I_{RRM}	Peak reverse current.	-	-	300	Rated V_{RRM} , note 2.	mA
V_{GT}	Gate trigger voltage	-	-	3.0	$T_j=25^\circ C.$	V
I_{GT}	Gate trigger current	-	-	300	$T_j=25^\circ C.$ $V_D=10V,$ $I_A=3A$	mA
I_H	Holding current	-	-	1000	$T_j=25^\circ C.$	mA
R_θ	Thermal resistance junction to sink.	-	-	9	Double side cooled.	K/KW
		-	-	18	Single side cooled.	K/KW
F	Mounting force.	81	-	98		kN
W_t	Weight.	-	2.80	-		kg

Notes:-

- 1) Unless otherwise indicated $T_j=125^\circ C.$
- 2) Leakage current limit, this will be increased in the future to 400mA

Notes on Ratings and Characteristics

1 Voltage Grade Table

Voltage Grade 'H'	V_{DSM} V	V_{DRM} V	V_{RRM} V	V_{RSM} V	V_D V	V_R V_{DC}
12	1200			1300		780
14	1400			1500		900
16	1600			1700		1020
18	1800			1800		1080
20	2000			2100		1260
22	2200			2300		1380
24	2400			2500		1500
26	2600			2700		1620
28	2800			2900		1740

2 Extension of Voltage Grades

This report is applicable to other and higher voltage grades when supply has been agreed by Sales/Production.

3 De-rating Factor

A blocking voltage de-rating factor of 0.13% per °C is applicable to this device for T_J below 25 °C.

4 Repetitive dv/dt

Higher dv/dt selections are available up to 2000V/ μ s on request.

5 Computer modelling parameters

5.1 Device dissipation calculations

$$I_{AV} = \frac{-V_o + \sqrt{V_o^2 + 4 \cdot ff^2 \cdot r_s \cdot W_{AV}}}{2 \cdot ff^2 \cdot r_s}$$

Where $V_o = 0.800V$, $r_s = 0.100m\Omega$

$$W_{AV} = \frac{\Delta T}{R_{th}} \quad \Delta T = T_{jMax} - T_{Hs}$$

R_{th} = Supplementary thermal impedance, see table below.

ff = Form factor, see table below.

Supplementary Thermal Impedance (at 50Hz operating frequency)				
Conduction Angle	6 phase (60°)	3 phase (120°)	Half wave (180°)	d.c.
Square wave Double Side Cooled	0.0098	0.0095	0.0093	0.0090
Square wave Single Side Cooled	0.0196	0.0190	0.0186	0.0180
Sine wave Double Side Cooled	0.0096	0.0093	0.0090	
Sine wave Single Side Cooled	0.0196	0.0186	0.0180	

Form Factors				
Conduction Angle	60°	120°	180°	d.c.
Square wave	2.45	1.73	1.41	1
Sine wave	2.78	1.88	1.57	

5.2 Calculating V_T using ABCD coefficients

The on-state characteristic I_T vs V_T , on Fig. 9, is represented in two ways; (i) the well established V_0 and r_s tangent and (ii) a set of constants A, B, C, D, forming the coefficients of the representative equation for V_T in terms of I_T given below:

$$V_T = A + B \cdot \ln(I_T) + C \cdot I_T + D \cdot \sqrt{I_T}$$

The constants, derived by curve fitting software, are given in this report for both hot and cold characteristics where possible. The resulting values for V_T agree with the true device characteristic over a current range, which is limited to that plotted.

125°C Coefficients		25°C Coefficients	
A	8.5×10^{-1}	A	1.02×10^0
B	9.8×10^{-14}	B	-5.40×10^{-3}
C	1.0×10^{-4}	C	6.71×10^{-5}
D	-1.3×10^{-14}	D	7.12×10^{-4}

5.3 D.C. Thermal impedance calculation

$$r_t = \sum_{p=1}^{p=n} r_p \left(1 - e^{\frac{-t}{\tau_p}} \right)$$

Where $p = 1$ to n , n is the number of terms in the series.

t = Duration of heating pulse in seconds.

r_t = Thermal resistance at time t .

r_p = Amplitude of r_{th} term.

τ_p = Time Constant of r_{th} term.

D.C. Double Side Cooled			
Term	1	2	3
r_p	4.06E-03	2.91E-03	1.92E-03
τ_p	1.42E+00	2.92E-01	3.16E-02

D.C. Single Side Cooled			
Term	1	2	3
r_p	1.2E-02	5.10E-03	9.95E-04
τ_p	1.23E+01	2.88E-01	8.57E-04

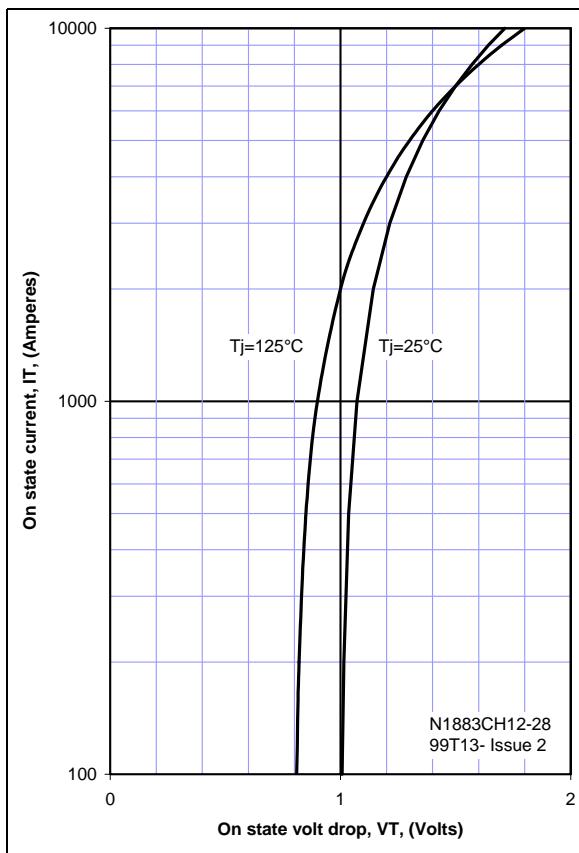
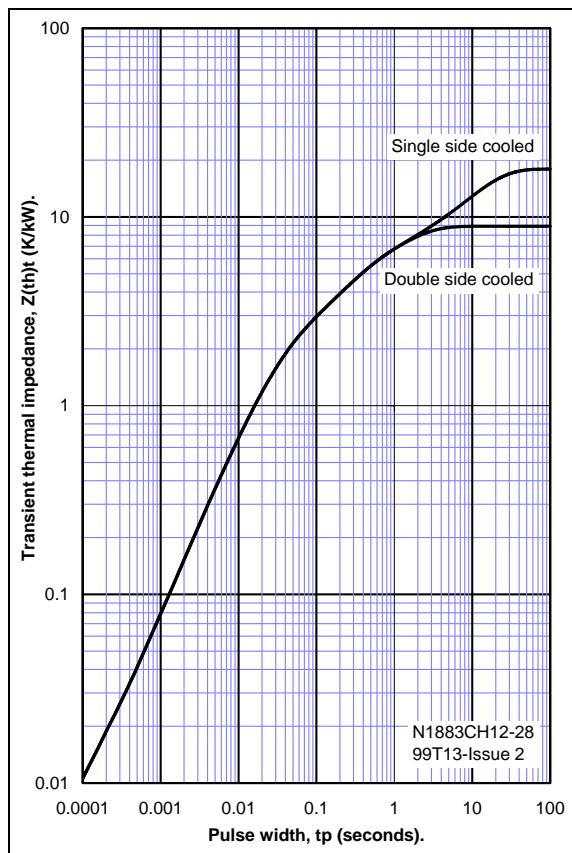
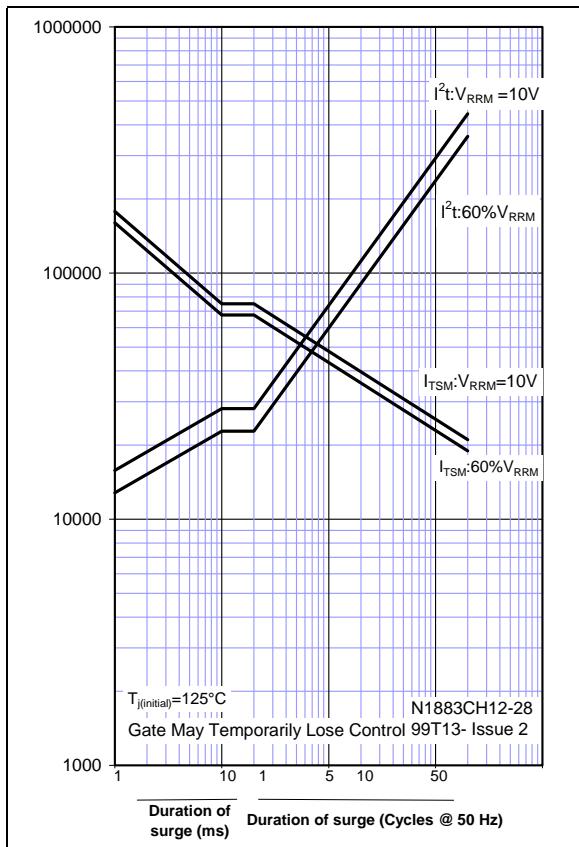
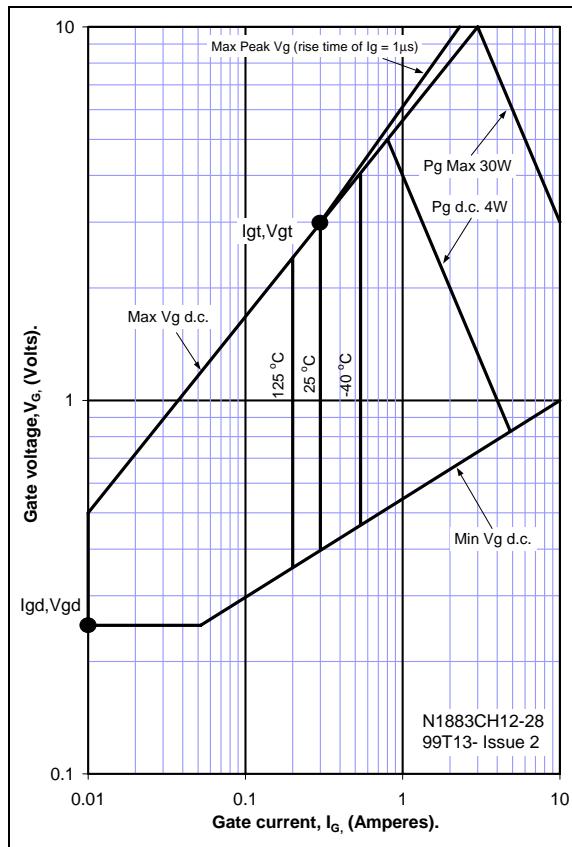
Curves**Figure 1, Maximum on-state characteristic****Figure 2, Transient thermal impedance****Figure 3, Maximum non repetitive surge****Figure 4, Gate characteristics, 25°C**

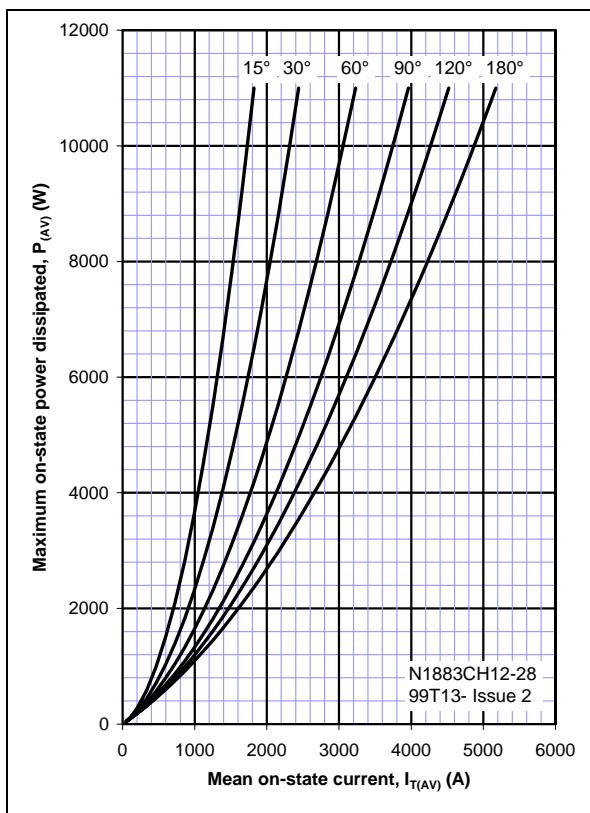
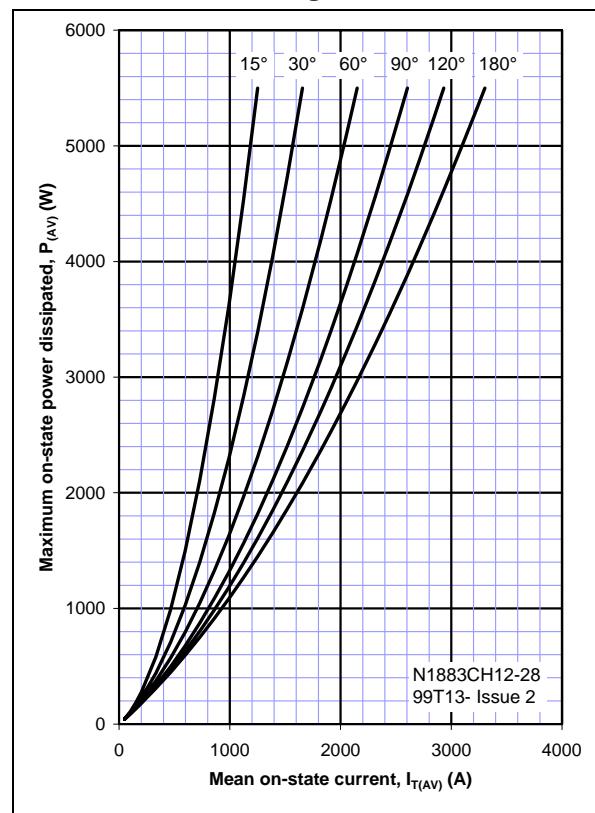
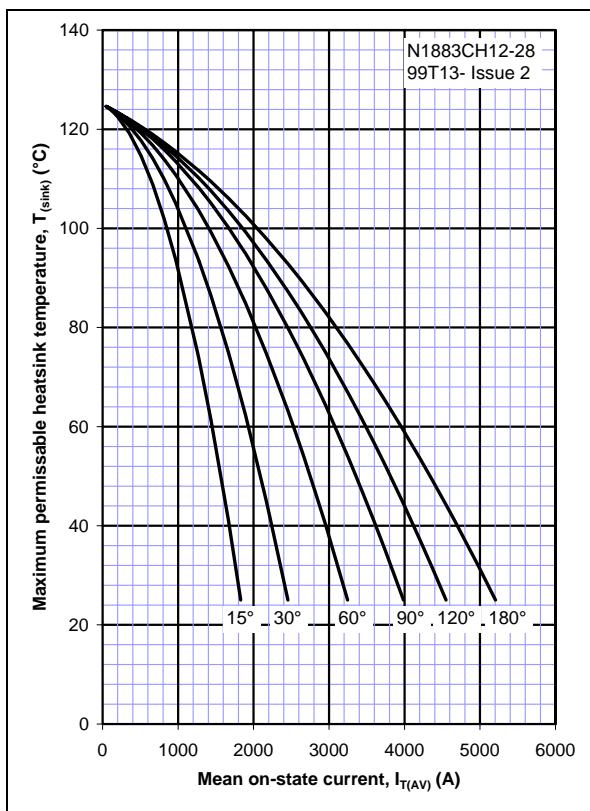
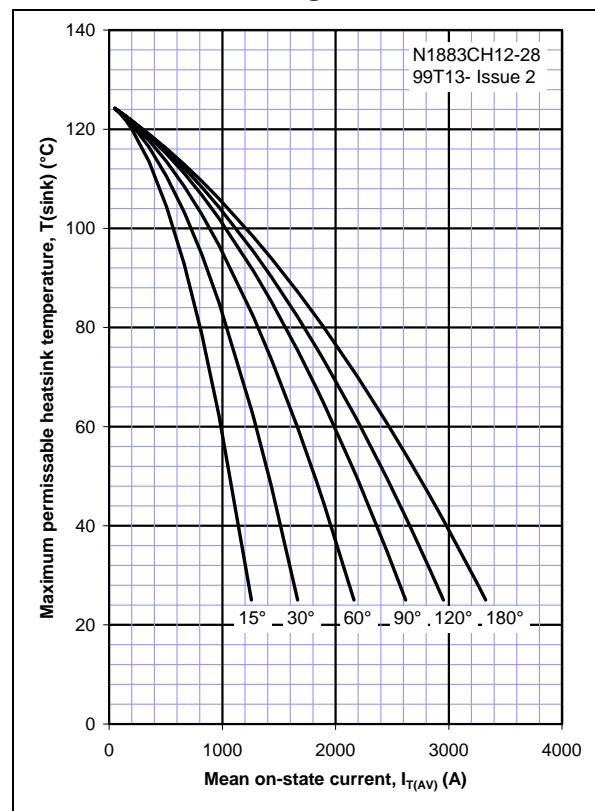
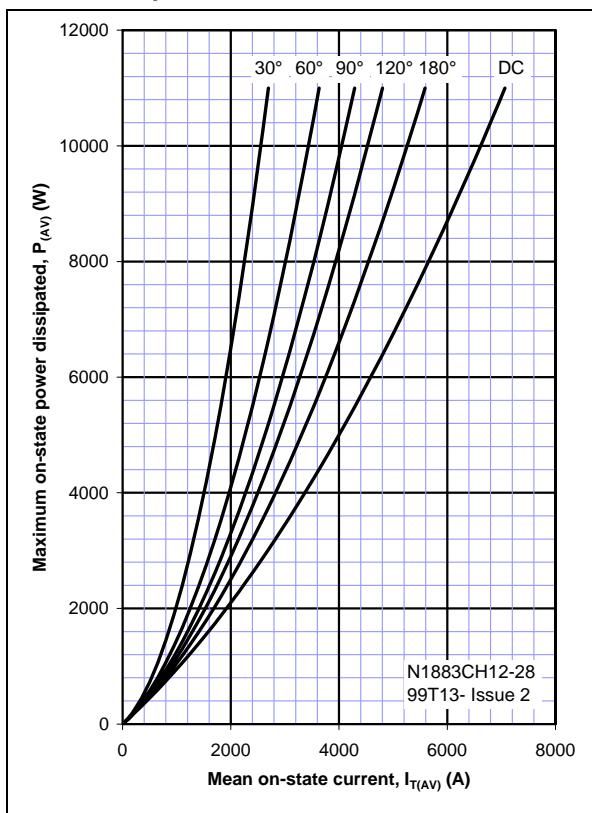
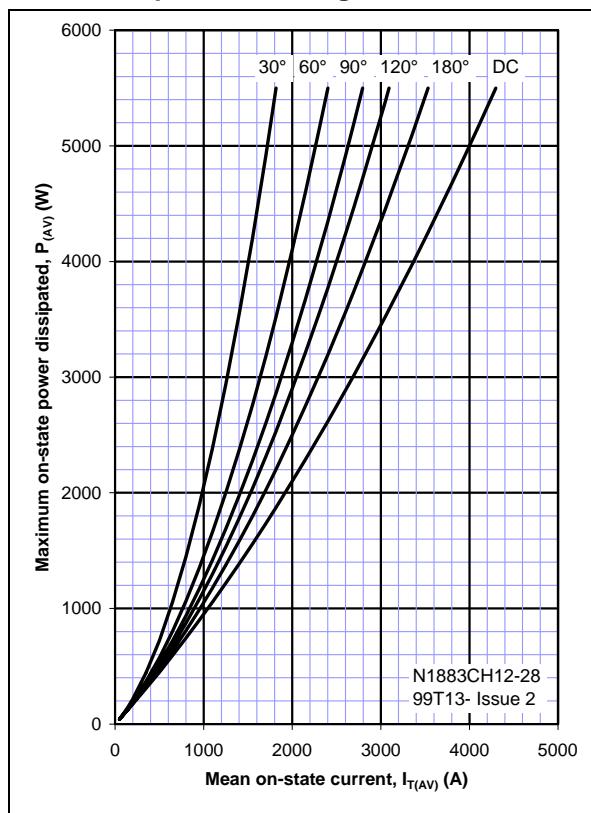
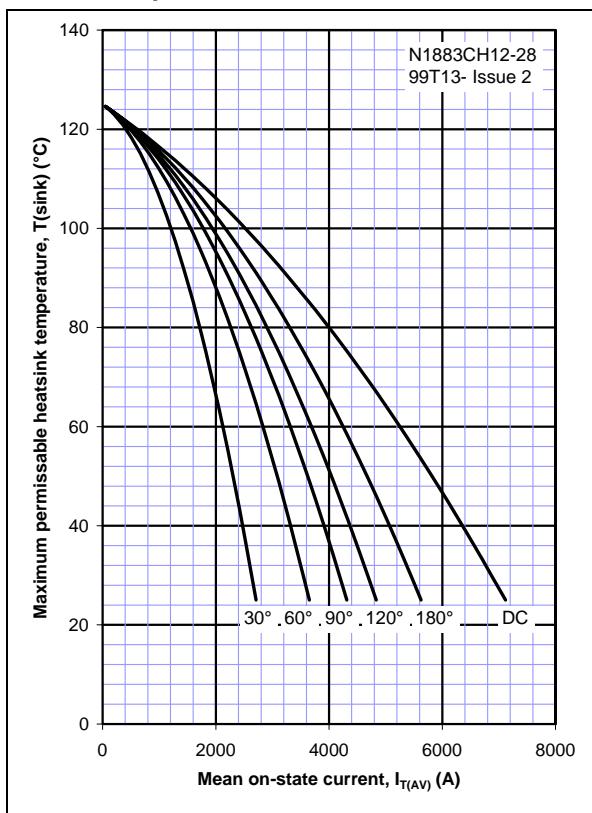
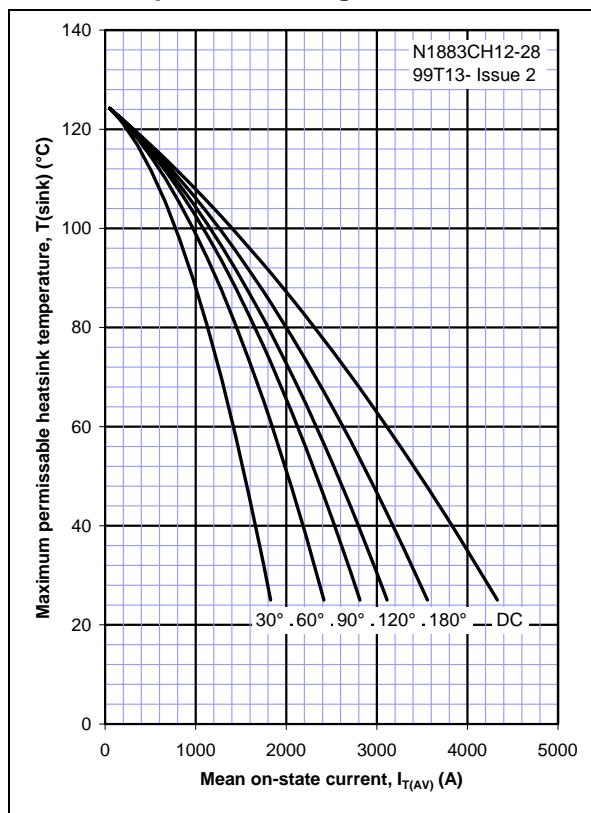
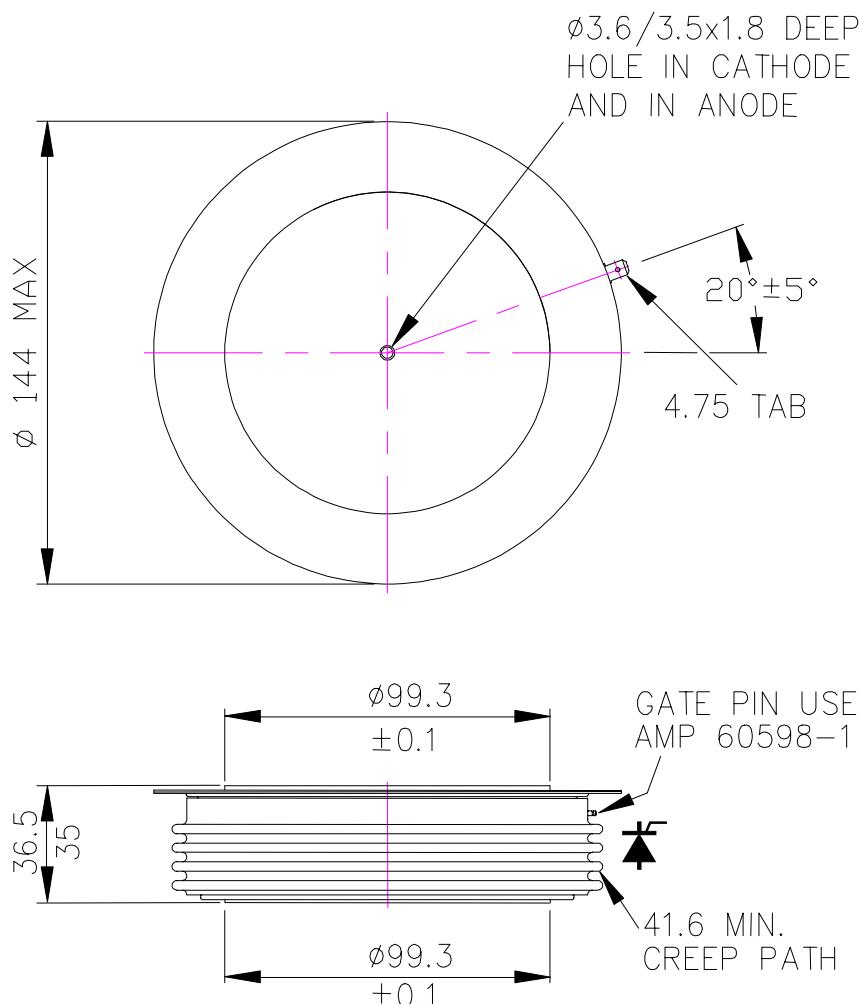
Figure 5, Power dissipation vs. mean current, sinewave, double side cooled**Figure 6, Power dissipation vs. mean current, sinewave, single side cooled****Figure 7, Heatsink temperature vs. mean current, sinewave, double side cooled****Figure 8, Heatsink temperature vs. mean current, sinewave, single side cooled**

Figure 9, Power dissipation vs. mean current, squarewave, double side cooled**Figure 10, Power dissipation vs. mean current, squarewave, single side cooled****Figure 11, Heatsink temperature vs. mean current, squarewave, double side cooled****Figure 12, Heatsink temperature vs. mean current, squarewave, single side cooled**

Outline drawing & ordering information



101A322

ORDERING INFORMATION

(Please quote 12 digit code as below)

N1283	C	◆	◆◆	◆◆◆
Fixed Type Code	Outline Code	H – standard explosion Z – enhanced explosion	V _{DRM} / 100	dv/dt Code Blank = 200V/μs JOO = 500V/μs GOO = 300V/μs KOO = 750V/μs HOO = 400V/μs LOO = 1000V/μs

Typical order code : N1883CZ28 – 2.8kV V_{DRM}, enhanced explosion rating capsule thyristor**WESTCODE**<http://www.westcode.com>

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